


<b>Search Notes</b>  	<b>Application/Control No.</b>  10593424	<b>Applicant(s)/Patent Under Reexamination</b>  RITTER ET AL.
	<b>Examiner</b>  Hai Phan	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
381	381, 327, 110, 56, 57, 71.1, 92, 94.1	10/05/10	HP

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	10/05/10	HP
EAST Search	10/05/10	HP
Update Search	03/21/11	HP
Update Search	09/24/11	HP
Update Search	02/06/12	HP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/HAI PHAN/ Primary Examiner.Art Unit 2614
--	--